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System and method for canceling signal source noise when measuring residual noise of a device under test (DUT)

Abstract

A system for canceling signal source noise when measuring residual noise of a DUT includes a signal source for generating an RF signal having signal source noise; a signal splitter for dividing the RF signal into first and second RF signals in first and second paths, the first path including the DUT which outputs a DUT signal in response to the first RF signal; a first receiver for receiving the DUT and second RF signals, compensating for a delay difference and eliminating the signal source noise to output a delay compensated first signal without the signal source noise; a second receiver receiving the DUT and second RF signals, compensating for a delay difference and eliminating the signal source noise to output a delay compensated second signal without the signal source noise; and a processor for performing cross-correlation of the delay compensated first and second signals for measuring the residual noise.

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Background/Summary

BACKGROUND

- (1) During testing of a device under test (DUT), the DUT may be configured to output a test signal in response to a stimulate signal provided by a signal source. When measuring the residual noise of the DUT, phase noise and amplitude modulation (AM) noise of the signal source must be canceled in order to measure only noise introduced by the DUT itself. Generally, cancelation of the phase noise and the AM noise of the signal source is done by subtracting the source signal generated by the signal source, including the phase noise and the AM noise, from DUT output signal in the frequency domain (or multiplying in the time domain).
- (2) To minimize degradation of the cancelation, the delay difference between the two paths must be minimized, for example, by adjusting the cable length of one or both paths, or by inserting a variable delay line in one or both paths. Both adjusting the cable length(s) and inserting variable delay line(s) are difficult and time-consuming procedures, requiring iterative observations of the

source noise at a phase detector and changing electrical delay as required. The result of adjusting the delay is usually not sufficient for low noise measurements.

(3) Also, path delay may be calculated by the electrical length of cables used, but such calculations do not provide sufficient accuracy. Using test instruments, such as a vector network analyzer (VNA), it is possible to measure delay accurately, but it requires reconnection of devices and cables. Another problem is that delay measurement by a VNA is not performed under the condition of residual noise measurement. Factors such as source and load matching, input power and nonlinearity of the DUT will cause error in the delay measured by the VNA.

Description

BRIEF DESCRIPTION OF THE DRAWINGS

- (1) The example embodiments are best understood from the following detailed description with the accompanying drawing figures. It is emphasized that the various features are not necessarily drawn to scale. In fact, the dimensions may be arbitrarily increased or decreased for clarity of discussion. Wherever applicable and practical, like reference numerals refer to like elements.
- (2) FIG. **1** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including digital demodulation, according to a representative embodiment.
- (3) FIG. **2** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including digital demodulation, according to a representative embodiment.
- (4) FIG. **3** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including frequency conversion and digital demodulation, according to a representative embodiment.
- (5) FIG. **4** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including frequency conversion, digital demodulation and cross-correlation, according to a representative embodiment.
- (6) FIG. **5** is as graph showing measurements of residual phase noise of a DUT signal without and with delay compensation, according to a representative embodiment.
- (7) FIG. **6** is a simplified block diagram of a system for calibrating a system for canceling signal source noise when measuring residual noise of a DUT, according to a representative embodiment.
- (8) FIG. **7** is a graph showing a modulation signal used for calibration, according to a representative embodiment.
- (9) FIG. **8** is a simplified block diagram of a system for calibrating a system for canceling signal source noise when measuring residual noise of a DUT, according to a representative embodiment.
- (10) FIG. **9**A is a flow diagram showing a method of canceling signal source noise when measuring residual noise of a DUT, including frequency conversion using a local oscillator, according to a representative embodiment.
- (11) FIG. **9**B is a continuation of the flow diagram showing a method of canceling signal source noise when measuring residual noise of a DUT, including frequency conversion using a local oscillator, according to a representative embodiment.
- (12) FIG. **10** is a simplified block diagram of a representative processing unit, according to a representative embodiment.

DETAILED DESCRIPTION

(13) In the following detailed description, for purposes of explanation and not limitation, representative embodiments disclosing specific details are set forth in order to provide a thorough understanding of an embodiment according to the present teachings. Descriptions of known systems, devices, materials, methods of operation and methods of manufacture may be omitted so

as to avoid obscuring the description of the representative embodiments. Nonetheless, systems, devices, materials and methods that are within the purview of one of ordinary skill in the art are within the scope of the present teachings and may be used in accordance with the representative embodiments. It is to be understood that the terminology used herein is for purposes of describing particular embodiments only and is not intended to be limiting. The defined terms are in addition to the technical and scientific meanings of the defined terms as commonly understood and accepted in the technical field of the present teachings.

- (14) It will be understood that, although the terms first, second, third etc. may be used herein to describe various elements or components, these elements or components should not be limited by these terms. These terms are only used to distinguish one element or component from another element or component. Thus, a first element or component discussed below could be termed a second element or component without departing from the teachings of the present disclosure. (15) The terminology used herein is for purposes of describing particular embodiments only and is not intended to be limiting. As used in the specification and appended claims, the singular forms of terms "a," "an" and "the" are intended to include both singular and plural forms, unless the context clearly dictates otherwise. Additionally, the terms "comprises," and/or "comprising," and/or similar terms when used in this specification, specify the presence of stated features, elements, and/or components, but do not preclude the presence or addition of one or more other features, elements, components, and/or groups thereof. As used herein, the term "and/or" includes any and all combinations of one or more of the associated listed items.
- (16) Unless otherwise noted, when an element or component is said to be "connected to," "coupled to," or "adjacent to" another element or component, it will be understood that the element or component can be directly connected or coupled to the other element or component, or intervening elements or components may be present. That is, these and similar terms encompass cases where one or more intermediate elements or components may be employed to connect two elements or components. However, when an element or component is said to be "directly connected" to another element or component, this encompasses only cases where the two elements or components are connected to each other without any intermediate or intervening elements or components. (17) The present disclosure, through one or more of its various aspects, embodiments and/or specific features or sub-components, is thus intended to bring out one or more of the advantages as specifically noted below. For purposes of explanation and not limitation, example embodiments disclosing specific details are set forth in order to provide a thorough understanding of an embodiment according to the present teachings. However, other embodiments consistent with the present disclosure that depart from specific details disclosed herein remain within the scope of the appended claims. Moreover, descriptions of well-known apparatuses and methods may be omitted so as to not obscure the description of the example embodiments. Such methods and apparatuses are within the scope of the present disclosure.
- (18) The various embodiments are in the technical field of measuring and testing electrical devices, and are directed more particularly to measuring residual noise of a DUT and canceling phase noise and AM noise of a signal source when measuring the residual noise of the DUT. More particularly, the various embodiments accurately compensate for delay differences between two paths, and cancel noises from the signal source sufficiently without using physical and/or electrical adjustments of the test system.
- (19) According to a representative embodiment, a system is provided for canceling signal source noise when measuring residual noise of a DUT. The system includes a signal source, a signal splitter, a path delay compensator, a subtractor, and a processor. The signal source is configured to generate a radio frequency (RF) signal having signal source noise, and to selectively generate a phase modulation signal to provide a phase modulated RF signal for initially performing a calibration of the system including the DUT. The signal splitter is configured to divide the RF signal into a first RF signal in a first path and a second RF signal in a second path, where the first

path introduces a first path delay, and includes the DUT configured to receive the first RF signal as a stimulus signal and to output a DUT signal in response; a first analog to digital converter (ADC) configured to digitize the DUT signal; and a first demodulator configured to demodulate the digitized DUT signal to provide a demodulated digitized DUT signal including the signal source noise of the RF signal and the residual noise of the DUT, and where the second path introduces a second path delay, and includes a second ADC configured to digitize the second RF signal; and a second demodulator configured to demodulate the digitized second RF signal to provide a demodulated digitized second RF signal. The path delay compensator is configured to compensate for a delay difference between the first path delay and the second path delay. The subtractor is configured to subtract the demodulated digitized DUT signal and the demodulated digitized second RF signal following the compensation for the delay difference to output a delay compensated signal including the residual noise of the DUT without the signal source noise. The processor is configured to initially perform the calibration of the system in response to the phase modulated RF signal with the DUT in the first path to determine the delay difference between the first path delay and the second path delay, and subsequently to measure the residual noise of the DUT from the delay compensated signal using the delay difference.

- (20) According to another representative embodiment, a system is provided for canceling signal source noise when measuring residual noise of a DUT. The system includes a signal source, a signal splitter, a first receiver unit, a second receiver unit and a processor. The signal source is configured to generate an RF signal having signal source noise. The signal splitter is configured to divide the RF signal into a first RF signal in a first path and a second RF signal in a second path, where the first path introduces a first path delay and the second path introduces a second path delay, and where the first path includes the DUT configured to receive the first RF signal as a stimulus signal and to output a DUT signal in response. The first receiver unit includes a third path configured to receive the DUT signal from the first path and a fourth path configured to receive the second RF signal from the second path, where the third path introduces a third path delay and the fourth path introduces a fourth path delay, and where the first receiver unit is configured to compensate for a delay difference between a sum of the first and third path delays and a sum of the second and fourth path delays and to eliminate the signal source noise to output a delay compensated first signal including first residual noise of the DUT without the signal source noise. The second receiver unit includes a fifth path configured to receive the DUT signal from the first path and a sixth path configured to receive the second RF signal from the second path, where the fifth path introduces a fifth path delay and the sixth path introduces a sixth path delay, and where the second receiver unit is configured to compensate for a delay difference between a sum of the first and fifth path delays and a sum of the second and sixth path delays and to eliminate the signal source noise to output a delay compensated second signal including second residual noise of the DUT without the signal source noise. The processor is configured to perform cross-correlation of the delay compensated first signal and the delay compensated second signal, and to measure the residual noise of the DUT from the cross-correlated signal.
- (21) According to another representative embodiment, a method is provided for canceling signal source noise when measuring residual noise of a DUT. The method includes generating an RF signal having signal source noise using a signal source; dividing the RF signal into a first RF signal in a first path and a second RF signal in a second path, where the first path introduces a first path delay and the second path introduces a second path delay; receiving the first RF signal as a stimulus signal at the DUT in the first path, where the DUT outputs a DUT signal in response; receiving the DUT signal at a third path and the second RF signal at a fourth path of a first receiver unit, where the third path introduces a third path delay and the fourth path introduces a fourth path delay; converting a frequency of the DUT signal using a first local oscillator (LO) signal generated by a first LO to a first frequency converted DUT signal, and a frequency of the second RF signal using the first LO signal to a first frequency converted RF signal, where the first LO introduces

first LO noise; compensating for a delay difference between a sum of the first and third path delays and a sum of the second and fourth path delays and eliminate the signal source noise to output a delay compensated first signal including first residual noise of the DUT without the signal source noise; receiving the DUT signal at a fifth path and the second RF signal at a sixth path of a second receiver unit, where the fifth path introduces a fifth path delay and the sixth path introduces a sixth path delay; converting a frequency of the DUT signal using a second LO signal generated by a second LO to a second frequency converted DUT signal, and a frequency of the second RF signal using the second LO signal to a second frequency converted RF signal, where the second LO introduces second LO noise; compensating for a delay difference between a sum of the first and fifth path delays and a sum of the second and sixth path delays and eliminate the signal source noise to output a delay compensated second signal including second residual noise of the DUT without the signal source noise; performing cross-correlation of the delay compensated first signal and the delay compensated second signal, eliminating the first and second LO noise; and outputting the cross-correlated signal as the residual noise of the DUT.

- (22) FIG. **1** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, according to a representative embodiment.
- (23) Referring to FIG. 1, test system 100 is configured to perform residual noise measurements of a DUT 111, and to cancel signal source noise introduced by signal source 101 from the residual noise measurements. The signal source noise may include phase noise and amplitude modulation (AM) noise of the signal source 101, for example. The signal source 101 may be a signal generator, a direct digital synthesizer (DDS) or an arbitrary waveform generator (AWG), for example, configured to generate a radio frequency (RF) signal as a stimulus signal to be input to the DUT 111. Of course, other types of signal generators may be incorporated as the signal source 101 without departing from the scope of the present teachings. As discussed above, the RF signal has source noise, including phase noise and/or AM noise, introduced by the signal source 101, which must be eliminated in order to accurately measure noise of the DUT 111.
- (24) The test system **100** includes a signal splitter **105** configured to divide the RF signal into multiple paths. The signal splitter **105** may be a power divider, for example. In the depicted embodiment, the signal splitter **105** divides the RF signal into a first RF signal input to a first path **110** and a second RF signal input to a second path **120**. For purposes of illustration, the DUT **111** is shown in the first path **110**, where the DUT **111** receives the first RF signal as a stimulus signal and outputs the DUT signal in response.
- (25) The test system **100** further includes a first receiver **112** in the first path **110** that receives the DUT signal output by the DUT **111**, and a second receiver **122** in the second path **120** that receives the second RF signal. The first receiver **112** includes a first analog to digital converter (ADC) **114** configured to digitize the DUT signal to output a digitized DUT signal. The second receiver **122** includes a second ADC **124** configured to digitize the second RF signal to output a digitized second RF signal.
- (26) A demodulator **106** demodulates the digitized DUT signal to baseband in response to a demodulation signal, for which the digitized second RF signal is used. This results in the demodulator **106** effectively subtracting the demodulated digitized DUT signal from the first path **110** and the demodulated digitized second RF signal from the second path **120** to eliminate the signal source noise from the DUT signal, enabling accurate measurement of the residual noise introduced by the DUT **111**. However, a delay difference between the first and second paths **110** and **120** must be compensated for. That is, the first path **110** introduces a first path delay in the DUT signal, and the second path **120** introduces a second path delay in the second RF signal, where the first path delay and the second path delay are different from one another. For the sake of convenience, the first path delay is assumed to be zero, such that the second path delay, indicated by path delay **121**, is equal to the delay difference (τ). The second path **120** therefore further includes a path delay compensator **125** configured to compensate for the delay difference between

- the first path delay and the second path delay by effectively subtracting out the path delay **121** (delay difference $(-\tau)$) prior to the subtraction performed by the demodulator **106**. Of course, in various alternative configurations, the path delay compensator **125** alternatively may be included in the first path **110** following the first ADC **114**, or the functionality of the path delay compensator **125** may be split between the first and second paths **110** and **120**, without departing from the scope of the present teachings. The demodulator **106** outputs a delay compensated signal including the residual noise of the DUT **111** without the signal source noise.
- (27) A processing unit **130** (e.g., digital signal processor) is configured to measure the residual noise of the DUT **111** in the delay compensated signal received from the demodulator **106**. An example of the processing unit **130** is discussed below in detail with reference to FIG. **10**.
- (28) More particularly, with reference to FIG. **1**, the RF signal output by the signal source **101** may be indicated by Expression (1), where $\omega = 2\pi f$ where f is carrier frequency of the RF signal, ω .sub.m= $2\pi f$.sub.m where f.sub.m is offset frequency from the carrier frequency of the RF signal, and Oss is phase noise of the RF signal:

 $\sin(\omega t + \phi. \sin \omega. \sin \omega. \sin \omega)$ (1)

- (29) The digitized DUT signal output by the first ADC **114** in the first path **110** may be indicated by Expression (2), where ϕ .sub.DUT is phase noise of the digitized DUT signal: $\sin(\omega t + \phi. \sin \omega. \sin \omega. \sin \omega. \sin \omega. \sin \omega)$ (2)
- (30) The digitized second RF signal output by the second ADC **124** in the second path **120** may be indicated by Expression (3), where t is the delay difference between the first and second paths **110** and **120**, indicated by the path delay **121** as discussed above:
- $\sin(\omega(t-\tau)+\phi.\text{sub.ss sin }\omega.\text{sub.m}(t-\tau))$ (3)
- (31) The value of the delay difference t may be determined during calibration of the test system **100**, as discussed below.
- (32) As mentioned above, the path delay compensator **125** compensates for the delay difference between the first and second path delays by effectively subtracting out the path delay **121** in the second path **120**. Therefore, after the path delay compensator **125**, the digitized second RF signal may be indicated by Expression (4), which has been compensated for the delay difference t: $\sin(\omega t + \phi. \sin \omega. \sin \omega)$ (4)
- (33) The demodulator **106** demodulates the digitized DUT signal indicated by Expression (2) to baseband in response to a demodulation signal, which is provided as the delay compensated digitized second RF signal indicated by Expression (4). Accordingly, the demodulation by the demodulator **106** effectively performs subtraction of the demodulated digitized DUT signal and the demodulated delay compensated digitized second RF signal to provide the delay compensated signal, which includes the residual noise of the DUT without the signal source noise, indicated by Expression (5):

Φ.sub.DUT sin ω.sub.mt (5)

- (34) In an embodiment, each of the first and second receivers may perform digital demodulation of the digitized DUT and second RF signals, respectively, as part of a practical implementation. In this context, FIG. **2** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including digital demodulation, according to a representative embodiment.
- (35) Referring to FIG. **2**, test system **200** is configured to perform residual noise measurements of a DUT **111**, and to cancel signal source noise introduced by signal source **101** from the residual noise measurements. The test system **200** has a first path **210** including a first receiver **212** and a second path **220** including a second receiver **222**. The test system **200** is substantially the same as the test system **100**, discussed above, with the addition of a signal oscillator **208**, a first demodulator **216** in the first receiver **212** and second demodulator **226** in the second receiver **222**, and replacing the demodulator **106** with a subtractor **206**, described below. The signal oscillator **208** may be a numerically controlled oscillator (NCO), for example, configured to generate a demodulation

- signal to be applied to both the first and second receivers **212** and **222**.
- (36) The first demodulator **216** in the first receiver **212** demodulates the digitized DUT signal to baseband in response to the demodulation signal, and the second demodulator **226** in the second receiver **222** demodulates the digitized second RF signal to baseband in response to the demodulation signal. The first and second demodulators **216** and **226** may be mixers, for example, although any type of demodulation may be implemented without departing from the scope of the present teachings.
- (37) In addition, the test system **200** includes path delay compensator **225** in place of the path delay compensator **125** for effectively subtracting out the path delay **121**. That is, the path delay compensator **225** is configured to effectively subtract out the path delay **121** by calculating compensation phase θ according to θ =2 π f.sub.mT, where f.sub.m is offset frequency from the carrier frequency of the RF signal and t is the delay difference between the first and second path delays, as discussed above, and subtracting the compensation phase θ from the demodulated digitized second RF signal to provide the delay compensated digitized second RF signal. Again, the path delay **121** and the path delay compensator **225** are indicated in the second path **220** for the sake of convenience. Of course, the path delay compensator **225** alternatively may be included in the first path **210** following the first ADC **114**, or the functionality of the path delay compensator **225** may be split between the first and second paths **210** and **220**, without departing from the scope of the present teachings.
- (38) The test system **200** includes the subtractor **206** configured to provide the difference between the demodulated digitized DUT signal from the first path **210** and the demodulated second RF signal from the second path **220**, after the delay compensation between the first and second paths **210** and **220**. Descriptions of the remaining elements in FIG. **2** with the same reference numbers as in FIG. **1** will not be repeated, for ease of explanation.
- (39) In FIG. **2**, the digitized DUT signal output by the first ADC **114** in the first path **210** may be indicated by Expression (2), and the digitized second RF signal output by the second ADC **124** in the second path **220** likewise may be indicated by Expression (3), discussed above. However, the first demodulator **216** in the first receiver **212** demodulates the digitized DUT signal, and the second demodulator **226** in the second receiver **222** demodulates the digitized second RF signal. Accordingly, the demodulated digitized DUT signal output by the first demodulator **216** may be indicated by Expression (6):
- ϕ .sub.ss sin ω .sub.mt+ ϕ .sub.DUT sin ω .sub.mt (6)
- (40) Also, the demodulated digitized second RF signal output by the second demodulator **226** in the second path **220** may be indicated by Expression (7);
- φ.sub.ss sin ω.sub.m(t-τ) (7)
- (41) The path delay compensator **225** compensates for the delay difference between the first and second path delays by effectively subtracting out the path delay **121** in the second path **220** by calculating the compensation phase θ and subtracting it from the demodulated digitized second RF signal, as discussed above, to provide the delay compensated digitized second RF signal. Therefore, after the path delay compensator **225**, the delay compensated demodulated digitized second RF signal may be indicated by Expression (8), which has been compensated for the delay difference τ :
- ϕ .sub.ss sin ω .sub.mt (8)
- (42) The subtractor **206** effectively subtracts the delay compensated, demodulated digitized second RF signal indicated by Expression (8) from the demodulated digitized DUT signal indicated by Expression (6) to provide the delay compensated signal, indicated by Expression (5), discussed above. The delay compensated signal includes the residual noise of the DUT without the signal source noise.
- (43) In an embodiment, the second path **220** may further include another DUT (not shown) before the second ADC **124**. In this case, the another DUT is configured to receive the second RF signal as

- a stimulus signal and to output another DUT signal in response. The another DUT signal is input to the second ADC **124**, which outputs a second DUT signal as the second RF signal, which is treated in the same manner as discussed above.
- (44) In another embodiment, each of the first and second receivers may perform frequency conversion (e.g., frequency down-conversion) of the DUT signal and the second RF signal before digitization and demodulation, respectively, as part of another practical implementation. In this context, FIG. **3** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including frequency conversion and digital demodulation, according to a representative embodiment.
- (45) Referring to FIG. **3**, test system **300** is configured to perform residual noise measurements of a DUT **111**, and to cancel signal source noise introduced by signal source **101** from the residual noise measurements. The test system **300** has a first path **310** including a first receiver **312** and a second path **320** including a second receiver **322**. The test system **300** is substantially the same as the test system **200**, discussed above, with the addition of a local oscillator (LO) **308**, a first frequency converter **316** in the first receiver **312**, and second frequency converter **326** in the second receiver **322**. The LO **308** is configured to generate an LO signal to be applied to both the first and second receivers **312** and **322**.
- (46) The first frequency converter **316** in the first receiver **312** converts the frequency of the DUT signal to an intermediate frequency in response to the LO signal prior to digitization, and second frequency converter **326** in the second receiver **322** converts the frequency of the second RF signal to the intermediate frequency in response to the LO signal prior to digitization, where the intermediate frequency is more manageable for the first and second ADCs **114** and **124** than the RF frequency of the RF signal. In an embodiment, the first and second frequency converters **316** and **326** are mixers configured to perform frequency down-conversion of the DUT signal and the second RF signal respectively. However, any type of frequency conversion may be implemented without departing from the scope of the present teachings.
- (47) The frequency converted DUT signal is digitized by the first ADC **114**, and the digitized DUT signal is demodulated to baseband by the first demodulator **216** in the first receiver **312**, as discussed above. The frequency converted second RF signal is digitized by the second ADC **124**, and the digitized second RF signal is demodulated to baseband by the second demodulator **226** in the second receiver **322**, as discussed above. Also, the second path **320** includes a path delay compensator **225** configured to compensate for the delay difference between the first path delay and the second path delay by effectively subtracting out the path delay **121** (delay difference (-τ)), as discussed above with reference to FIG. **2**. Again, the path delay compensator **225** alternatively may be included in the first path **310** following the first ADC **114**, or the functionality of the path delay compensator **225** may be split between the first and second paths **310** and **320**, without departing from the scope of the present teachings. The subtractor **206** effectively subtracts the delay compensated, demodulated digitized second RF signal from the demodulated digitized DUT signal to provide the delay compensated signal, indicated by Expression (5), discussed above. (48) In configuration shown in FIG. **3**, the path delay compensation has a side effect in that the LO
- **308** introduces LO noise, the cancellation of which is impaired by the delay added by the path delay compensator **225**. In comparison, without the compensation provided by the path delay compensator **225**, the LO noise introduced by the LO **308** may be sufficiently canceled by careful internal design. In order to reduce or eliminate the uncanceled LO noise caused as a side effect of the path delay compensation, cross-correlation may be performed, as discussed below.
- (49) That is, FIG. **4** is a simplified block diagram of a system for canceling signal source noise when measuring residual noise of a DUT, including frequency conversion, digital demodulation and cross-correlation, according to a representative embodiment. The cross-correlation may be performed by implementing two identical receiver units.
- (50) Referring to FIG. 4, test system 400 is configured to perform residual noise measurements of a

DUT 111, and to cancel signal source noise introduced by signal source 101 from the residual noise measurements, and to eliminate uncanceled LO noise introduced by first LO 308 and second LO 408, discussed below. The test system 400 includes the signal splitter 105 configured to divide the RF signal output by the signal source 101 into a first path 410 and a second path 420, where the DUT 111 is located in the first path 410. The first path 410 introduces a first path delay in the DUT signal e, and the second path 420 introduces a second path delay in the second RF signal, as discussed above. The test system 400 further includes a first receiver unit 401 and a second receiver unit 402 in both the first path 410 and the second path 420, where the first and second receiver units 401 and 402 are substantially the same. That is, the first receiver unit 401 includes first receiver 312 and the second receiver unit 402 includes third receiver 332 that are substantially the same as the first receiver 312 in test system 300, and the first receiver unit 401 includes second receiver 322 and the second receiver unit 402 includes fourth receiver 342 that are substantially the same as the second receiver 322 in the test system 300, discussed above.

- (51) More particularly, the first receiver unit **401** includes first LO **308** for generating an LO signal and first signal oscillator 208 for generating a demodulation signal for demodulators in the first and second receivers 312 and 322. As discussed above, the first receiver 312 includes first frequency converter **316** for converting the frequency of the DUT signal from the DUT **111** to an intermediate frequency in response to the LO signal, first ADC **114** for digitizing the frequency converted DUT signal, and first demodulator 216 for demodulating the digitized DUT signal in response to the demodulation signal. The second receiver 322 includes second frequency converter 326 for converting the frequency of the second RF signal to the intermediate frequency in response to the LO signal, second ADC **124** for digitizing the frequency converted second RF signal, and second demodulator **226** for demodulating the digitized second RF signal in response to the demodulation signal. The second receiver **322** further includes first path delay compensator **225** configured to compensate for the delay difference between the first path delay and the second path delay, although the functionality may be included in the first receiver **312** or split between the first and second receivers 312 and 322, as discussed above. The first receiver unit 401 further includes subtractor **206** for effectively subtracting the delay compensated, demodulated digitized second RF signal from the demodulated digitized DUT signal to provide first delay compensated signal. (52) The second receiver unit **402** includes second LO **408** for generating an LO signal and second signal oscillator **409** for generating a demodulation signal for demodulators in the third and fourth receivers **332** and **342**. The third receiver **332** includes third frequency converter **336** for converting the frequency of the DUT signal from the DUT **111** to an intermediate frequency in response to the LO signal, third ADC **134** for digitizing the frequency converted DUT signal, and third demodulator **236** for demodulating the digitized DUT signal in response to the demodulation signal. The fourth receiver **342** includes fourth frequency converter **346** for converting the frequency of the second RF signal to the intermediate frequency in response to the LO signal, fourth ADC **144** for digitizing the frequency converted second RF signal, and fourth demodulator **246** for demodulating the digitized second RF signal in response to the demodulation signal. The fourth receiver **342** further includes second path delay compensator **245** configured to compensate for the delay difference between the first path delay and the second path delay, although the functionality may be included in the third receiver **332** or split between the third and fourth receivers **332** and **342**, as discussed above with reference to first and second receivers **312** and **322**. The second receiver unit **402** further includes subtractor **406** for effectively subtracting the delay compensated, demodulated digitized second RF signal from the demodulated digitized DUT signal to provide second delay compensated signal.
- (53) As discussed above, the test system **400** is configured to perform cross-correlation between the first delay compensated signal output by the first receiver unit **401** and the second delay compensated signal output by the second receiver unit **402**. This is done by the processing unit **130**, which inputs the first and second delay compensated signals, and perform the cross-correlation, for

example, by multiplying the first delay compensated signal by the complex conjugate of the second delay compensated signal in the frequency domain. The cross-correlated signal is substantially free of noise introduced by the internal components of the first and second receiver units **401** and **402**, including the first and second LOs **308** and **408**, as well as uncanceled LO noise introduced by the first and second LOs **308** and **408** caused as a side-effect of the path delay compensation performed by the first and second path delay compensators **225** and **245**.

- (54) FIG. 5 is as graph showing measurements of residual phase noise of a DUT signal without and with delay compensation, according to a representative embodiment. Referring to FIG. 5, trace 501 shows the residual phase noise of the DUT signal in dBc/Hz without delay compensation, where residual phase noise increases significantly at higher offset frequencies, beginning at about 1 MHz. In comparison, trace **502** shows the residual phase noise of the DUT signal in dBc/Hz with delay compensation, according to a representative embodiment, where the residual phase noise continues to decline and then remains substantially flat at offset frequencies at and above about 1 MHz. (55) Notably, in the systems discussed above for canceling signal source noise when measuring residual noise with path delay compensation, the difference in the delay of the first and second paths, represented by path delay 121 in FIGS. 1-4, should be provided in advance. The improvement of the source noise cancelation by the path delay compensation directly depends on how accurately the delay difference is represented. In other words, the greater the error in the delay difference provided to the system, the less effective the signal source noise cancelation will be. (56) Conventionally, the respective path delays and the corresponding delay difference may be estimated based on the electrical lengths of cables used in the first and second paths. However, such estimation does not consistently provide sufficient accuracy for performing effective path delay compensation. For more accuracy, a test instruments, such as vector network analyzers (VNAs), may be used to measure the respective path delays. However, use of such instruments tends to be time consuming in that the devices and cables involved need to be connected to the VNA and then reconnected for performing the residual noise measurement of the DUT. Also, the delay measurement by a VNA is not done under the same conditions as the subsequent residual noise measurement. Source and load match, input power and nonlinearity of the DUT will cause error of measured delay. Accordingly, a calibration system is needed to perform an accurate determination of the delay difference between paths.
- (57) FIG. **6** is a simplified block diagram of a calibration system for calibrating a system for canceling signal source noise when measuring residual noise of a DUT, according to a representative embodiment.
- (58) Referring to FIG. **6**, calibration system **200-1** is substantially the same as the test system **200**, discussed above, with the addition of a modulation source **601** connectable to the signal source **101** through operation of a calibration switch **605**. The modulation source **601** is configured to provide a phase modulation signal to the signal source **101** to generate a phase modulated RF signal for initially calibrating the test system **200**, as well as the test systems **300** and **400**, discussed above. The calibration determines the delay difference (t) between the first path delay in the first path **210** and the second path delay in the second path 220 with the DUT 111 included in the first path 210 during the calibration and subsequent measurement of residual noise. The calibration is therefore done under actual measurement conditions, including the operating conditions of the DUT **111**. (59) The phase modulation signal provided by the modulation source **601** is indicated by ϕ .sub.CAL sin ω .sub.Mt, where ω .sub.M= $2\pi f$.sub.M where f.sub.M is modulation frequency. In the depicted embodiment, a calibration switch **605** is configured to selectively connect the modulation source **601** to the signal source **101**. Although the modulation source **601** is depicted separate from the signal source **101**, it is understood that the functionality of the modulation source **601** may be incorporated into the signal source **101** when the signal source **101** is capable of providing the phase modulation signal itself for generating the phase modulated RF signal. For example, when the signal source **101** comprises an AWG, it is able to generate the phase modulated RF signal

itself.

- (60) When the modulation source **601** provides the phase modulation signal to the signal source **101**, e.g., when the calibration switch **605** is closed, the signal source **101** outputs an RF signal that is phase modulated at the modulation frequency (f.sub.M) to provide a phase modulated RF signal. The signal splitter **105** divides the phase modulated RF signal into a phase modulated first RF signal directed to the first path **210** and a phase modulated second RF signal directed to the second path **220**. The phase modulated first RF signal is input as a stimulus signal to the DUT **111**, which outputs a phase modulated DUT signal in response. The first ADC **114** in the first receiver **212** digitizes the phase modulated DUT signal to output a digitized phase modulated DUT signal to output a digitized phase modulated second RF signal to output a digitized phase modulated second RF signal.
- (61) The calibration system **200-1** further includes signal oscillator **208**, first demodulator **216** following the first ADC **114** in the first receiver **212**, and second demodulator **226** following the second ADC **124** in the second receiver **222**. The first demodulator **216** demodulates the digitized phase modulated DUT signal to baseband in response to the demodulation signal, and the second demodulator **226** demodulates the digitized phase modulated second RF signal to baseband in response to the demodulation signal, as discussed above.
- (62) The subtractor **206** is disconnected during the calibration, indicated by the dotted line. Therefore, the digitized phase modulated DUT signal and the digitized phase modulated second RF signal are provided to the processing unit **130** without being subtracted to remove the phase modulation signal from the digitized phase modulated DUT signal.
- (63) The calibration system **200-1** is initially calibrated by setting the path delay compensation provided by the path delay compensator **225** to zero by the processing unit **130**. The processing unit **130** then measures first phase of the digitized phase modulated DUT signal from the first path **210** and second phase of the digitized phase modulated second RF signal from the second path **220**, and accurately calculates the delay difference (t) between the first path delay and the second path delay according to Equation (9):

delay according to Equation (9):

(64)
$$\tau = \frac{\sin^{-1}(\frac{\phi_2}{\text{.Math. } \phi_2 \text{.Math.}}) - \sin^{-1}(\frac{\phi_1}{\text{.Math. } \phi_1 \text{.Math.}})}{2\pi f_M} \quad (9)$$

- (65) In Equation (9), ϕ .sub.1 is the measured first phase of the phase modulated DUT signal that passes through the first path **210**, and ϕ .sub.2 is the measured second phase of the phase modulated second RF signal that passes through the second path **220**.
- (66) The modulation source **601** is then removed from the calibration system **200-1**, e.g., by opening the calibration switch **605**, and the subtractor **206** is reconnected between the first and second paths **210** and **220**, so that the calibration system **200-1** effectively becomes the test system **200**. The path delay compensator **225** is set to the delay difference (t) as calculated during the calibration by the processing unit **130**. The test system **200** is then able to accurately measure the residual noise of a DUT **111** by canceling the signal source noise of the signal source **101**, as discussed above, using the calibrated delay difference (t).
- (67) The amount of the phase modulation is ϕ .sub.CAL, which gives the magnitude of the phase modulation signal, should be small enough compared to carrier power not to change the operation condition and should be large enough that the signal source noise of the signal source **101** and the residual noise of the DUT **111** may be negligible. In this context, FIG. **7** is a graph showing a modulation signal used for calibration, according to a representative embodiment. Trace **715** shows the phase noise being measured. An arrow indicates frequency of the phase modulation signal of the modulation frequency f.sub.M having the magnitude indicated by ϕ .sub.CAL, mentioned above.
- (68) FIG. **8** is a simplified block diagram of another calibration system for calibrating a system for canceling signal source noise when measuring residual noise of a DUT, according to a representative embodiment.

- (69) Referring to FIG. **8**, like calibration system **200-1**, calibration system **200-2** is substantially the same as the test system **200**, discussed above, with the addition of the modulation source **601** connectable to the signal source **101**. The modulation source **601** is configured to provide phase modulation signal to the signal source **101** to generate a phase modulated RF signal for initially calibrating the test system **200**, as well as the test systems **100**, **300**, and **400**, discussed above. The calibration determines the delay difference (t) between the first path delay in the first path 210 and the second path delay in the second path 220 with the DUT 111 included in the first path 210 during the calibration and subsequent measurement of residual noise. The calibration is therefore done under actual measurement conditions, including the operating conditions of the DUT 111. (70) When the modulation source **601** provides a phase modulation signal to the signal source **101**, e.g., when the calibration switch **605** is closed, the signal source **101** outputs an RF signal that is phase modulated at the modulation frequency (f.sub.M) to provide a phase modulated RF signal. The signal splitter **105** divides the phase modulated RF signal into phase modulated first RF signal directed to the first path **210** and phase modulated second RF signal directed to the second path **220**. The phase modulated first RF signal is input as a stimulus signal to the DUT **111**, which outputs a phase modulated DUT signal in response. In the first receiver 212, the first ADC 114 digitizes the phase modulated DUT signal to output a digitized phase modulated DUT signal, and the first demodulator **216** demodulates the digitized phase modulated DUT signal to baseband in response to the demodulation signal generated by the signal oscillator **208**. In the second receiver 222, the second ADC 124 digitizes the phase modulated second RF signal to output a digitized phase modulated second RF signal, and the second demodulator 226 demodulates the digitized phase modulated second RF signal to baseband in response to the demodulation signal generated by the signal oscillator **208**.
- (71) The calibration system **200-2** further includes subtractor **206**, which is configured to subtract the digitized phase modulated DUT signal from the first path 210 and the digitized phase modulated second RF signal from the second path **220** to remove the modulation signal from the DUT signal. For the sake of convenience, the first path delay is assumed to be zero, such that the second path delay, indicated by path delay **121**, is equal to the delay difference (t). (72) The output of the subtractor **206** is provided to the processing unit **130** and a zero detector **805**, for purposes of calibration. The zero detector **805** is configured to detect when delay compensation applied during the calibration results is zero delay difference between the first and second path delays by measuring the magnitude of a residual modulation signal after subtraction by the subtractor **206**. An adjustable path delay compensator **825**, shown in the second receiver **222**, is configured to adjust the delay difference between the first path delay through the first path **210** and the second path delay through the second path **220** until the delay difference equals zero, as detected by zero detector **805**. To this end, the compensation setting of the path delay compensator **825** is adjusted by the processing unit **130**. That is, the processing unit **130** receives the delay difference signal from the zero detector **805** and adjusts a compensation setting of the path delay compensator **825** until the delay difference signal indicates no difference between the first path delay and the second path delay. The compensation setting of the path delay compensator **825** when the delay difference is detected to be zero becomes the calibrated delay difference (τ) . (73) Following calibration, the modulation source **601** is removed from the calibration system **200**-**2**, e.g., by opening the calibration switch **605**, and the path delay compensator **825** set to the calibrated delay difference (t), so that the calibration system **200-2** effectively becomes the test system **200**. The test system **200** is then able to cancel the signal source noise of the signal source

101, as discussed above, in order to accurately measure the residual noise of a DUT **111**, as

modulation frequency in the frequency range of interest.

discussed above, using the calibrated delay difference (t). Both the calibration system **200-1** and the calibration system **200-2** can determine the delay difference even when the delay is not flat over offset frequency from the carrier frequency of the RF signal to repeat the calibration changing the

- (74) FIGS. **9**A and **9**B provide a flow diagram showing a method of canceling signal source noise when measuring residual noise of a DUT, including frequency conversion using a local oscillator, according to a representative embodiment. The steps of FIGS. **9**A and **9**B may be performed all or in part by the test systems discussed above, including the processing unit **130**.
- (75) Referring to FIG. **9**A, an RF signal is generated using a signal source in block **S911**. The RF signal includes signal source noise introduced by the signal source.
- (76) In block S**912**, the RF signal is divided into a first RF signal in a first path and a second RF signal in a second path. The first path introduces a first path delay and the second path introduces a second path delay.
- (77) In block S**913**, the first RF signal is received at the DUT in the first as a stimulus signal. The DUT outputs a DUT signal in response to the stimulus signal.
- (78) In block S**914**, the DUT signal is received at a third path and the second RF signal is received at a fourth path of a first receiver unit. The third path introduces a third path delay and the fourth path introduces a fourth path delay.
- (79) In block S**915**, a frequency of the DUT signal is converted using a first local oscillator (LO) signal generated by a first LO to provide a first frequency converted DUT signal. Also, a frequency of the second RF signal is converted using the first LO signal to a first frequency converted second RF signal. The first LO introduces first LO noise in each of the first frequency converted DUT signal and the first frequency converted RF signal.
- (80) In block S**916**, the first frequency converted DUT signal and the first frequency converted second RF signal are digitized and demodulated in the third and fourth paths, respectively, to provide a first demodulated digitized DUT signal and a first demodulated digitized second RF signal.
- (81) In block S917, a delay difference between a sum of the first and third path delays and a sum of the second and fourth path delays is compensated for, and the first demodulated digitized DUT signal and the first demodulated digitized second RF signal are subtracted following the delay compensation to eliminate the signal source noise. The first receiver unit thus outputs a delay compensated first signal, which includes first residual noise of the DUT (including the first LO noise) without the signal source noise.
- (82) Referring to FIG. **9**B, the DUT signal is received at a fifth path and the second RF signal is received at a sixth path of a second receiver unit in block S**918**. The fifth path introduces a fifth path delay and the sixth path introduces a sixth path delay.
- (83) In block S**919**, a frequency of the DUT signal is converted using a second LO signal generated by a second LO in block S**919** to provide a second frequency converted DUT signal. Also, a frequency of the second RF signal is converted using the second LO signal to a second frequency converted second RF signal. The second LO introduces second LO noise in each of the second frequency converted DUT signal and the second frequency converted RF signal.
- (84) In block S**920**, the second frequency converted DUT signal and the second frequency converted second RF signal are digitized and demodulated in the fifth and sixth paths, respectively, to provide a second demodulated digitized DUT signal and a second demodulated digitized second RF signal.
- (85) In block S921, a delay difference between a sum of the first and fifth path delays and a sum of the second and sixth path delays is compensated for, and the second demodulated digitized DUT signal and the second demodulated digitized second RF signal are subtracted following the delay compensation to eliminate the signal source noise. The second receiver unit thus outputs a delay compensated second signal, which includes second residual noise of the DUT (including the second LO noise) without the signal source noise.
- (86) In block S**922**, cross-correlation is performed between the delay compensated first signal and the delay compensated second signal. Performing the cross-correlation eliminates the first and second LO noise to output the cross-correlated signal as the residual noise of the DUT.

- (87) FIG. **10** is a simplified block diagram of a representative processor unit, such as the processing unit **130** in FIGS. **1-4**, **6** and **8**, according to a representative embodiment.
- (88) Referring to FIG. **10**, processing unit **130** includes a processor **1010**, memory **1020** for storing instructions executable by the processor **1010** to implement the processes described herein, as well as a display **1030** and an interface **1040** to enable user interaction.
- (89) The processor **1010** is representative of one or more processing devices, and is configured to execute software instructions to perform functions as described in the various embodiments herein. The processor **1010** may be implemented by a general purpose computer, a central processing unit, one or more processors, microprocessors or microcontrollers, a state machine, a programmable logic device, field programmable gate arrays (FPGAs), application specific integrated circuits (ASICs), or combinations thereof, using any combination of hardware, software, firmware, hardwired logic circuits, or combinations thereof. The term "processor" encompasses an electronic component able to execute a program or machine executable instructions. References to a processor should be interpreted to include more than one processor or processing core, as in a multi-core processor, and/or parallel processors. Programs have software instructions performed by one or multiple processors that may be within the same computing device or which may be distributed across multiple computing devices.
- (90) The memory **1020** is a tangible storage medium for storing data and executable software instructions, and is non-transitory during the time software instructions are stored therein, and may communicate with each other and the processor **1010** via one or more buses. The memory **1020** stores instructions used to implement some or all aspects of methods and processes described herein, including the methods described above with reference to FIGS. 9A and 9B, for example. The memory **1020** may be implemented by any number, type and combination of random access memory (RAM) and read-only memory (ROM), for example, and may store various types of information, such as software algorithms and computer programs, all of which are executable by the processor **1010**. The various types of ROM and RAM may include any number, type and combination of computer readable storage media, such as a disk drive, flash memory, an electrically programmable read-only memory (EPROM), an electrically erasable and programmable read only memory (EEPROM), registers, a hard disk, a removable disk, tape, compact disk read only memory (CD-ROM), digital versatile disk (DVD), floppy disk, blu-ray disk, a universal serial bus (USB) drive, or any other form of storage medium known in the art. (91) The display **1030** may be a monitor such as a computer monitor, a television, a liquid crystal display (LCD), an organic light emitting diode (OLED), a flat panel display, a solid-state display, or a cathode ray tube (CRT) display, or an electronic whiteboard, for example. The display **1030** may also provide a graphical user interface (GUI) for displaying and receiving information to and from the user.
- (92) The interface **1040** may include a user and/or network interface for providing information and data output by the processor **1010** and/or the memory **1020** to the user and/or for receiving information and data input by the user. That is, the interface **1040** enables the user to enter data and to control or manipulate aspects of the processes described herein, and also enables the processor **1010** to indicate the effects of the user's control or manipulation. The interface **1040** may connect one or more user interfaces, such as a mouse, a keyboard, a mouse, a trackball, a joystick, a haptic device, a microphone, a video camera, a touchpad, a touchscreen, voice or gesture recognition captured by a microphone or video camera, for example, or any other peripheral or control to permit user feedback from and interaction with the processor **1010**. The interface **1040** may further include one or more of ports, disk drives, wireless antennas, or other types of receiver circuitry. (93) While the invention has been illustrated and described in detail in the drawings and foregoing description, such illustration and description are to be considered illustrative or exemplary and not restrictive; the invention is not limited to the disclosed embodiments. Other variations to the disclosed embodiments can be understood and effected by those having ordinary skill in the art in

practicing the claimed invention, from a study of the drawings, the disclosure, and the appended claims. In the claims, the word "comprising" does not exclude other elements or steps, and the indefinite article "a" or "an" does not exclude a plurality. The mere fact that certain measures are recited in mutually different dependent claims does not indicate that a combination of these measures cannot be used to an advantage.

(94) Aspects of the present invention may be embodied as an apparatus, method or computer program product. Accordingly, aspects of the present invention may take the form of an entirely hardware embodiment, an entirely software embodiment (including firmware, resident software, micro-code, etc.) or an embodiment combining software and hardware aspects that may all generally be referred to herein as a "circuit," "module" or "system." Furthermore, aspects of the present invention may take the form of a computer program product embodied in one or more computer readable medium(s) having computer executable code embodied thereon.

(95) While representative embodiments are disclosed herein, one of ordinary skill in the art appreciates that many variations that are in accordance with the present teachings are possible and remain within the scope of the appended claim set. The invention therefore is not to be restricted except within the scope of the appended claims.

Claims

- 1. A system for canceling signal source noise when measuring residual noise of a device under test (DUT), the system comprising: a signal source configured to generate a radio frequency (RF) signal having signal source noise, and to selectively provide a phase modulated RF signal for initially performing a calibration of the system including the DUT; a signal splitter configured to divide the RF signal into a first RF signal in a first path and a second RF signal in a second path, wherein the first path introduces a first path delay, and comprises the DUT configured to receive the first RF signal as a stimulus signal and to output a DUT signal in response; a first analog to digital converter (ADC) configured to digitize the DUT signal; and a first demodulator configured to demodulate the digitized DUT signal to provide a demodulated digitized DUT signal including the signal source noise of the RF signal and the residual noise of the DUT, and wherein the second path introduces a second path delay, and comprises a second ADC configured to digitize the second RF signal; and a second demodulator configured to demodulate the digitized second RF signal to provide a demodulated digitized second RF signal; a path delay compensator configured to compensate for a delay difference between the first path delay and the second path delay; a subtractor configured to subtract the demodulated digitized DUT signal and the demodulated digitized second RF signal following the compensation for the delay difference to output a delay compensated signal including the residual noise of the DUT without the signal source noise; and a processor configured to initially perform the calibration of the system in response to the phase modulated RF signal with the DUT in the first path to determine the delay difference between the first path delay and the second path delay, and subsequently to measure the residual noise of the DUT from the delay compensated signal using the delay difference.
- 2. The system of claim 1, wherein the second path further comprises another DUT before the second ADC, wherein the another DUT is configured to receive the second RF signal as a stimulus signal and to output another DUT signal in response, wherein the another DUT signal is input to the second ADC as the second RF signal.
- 3. The system of claim 1, further comprising: a local oscillator (LO) configured to generate an LO signal, wherein: the first path further comprises a first frequency converter configured to convert a frequency of the DUT signal using the LO signal to provide a frequency converted DUT signal to input the ADC, and the second path further comprises a second frequency converter configured to convert a frequency of the second RF signal using the LO signal to provide a frequency converted second RF signal to input the ADC.

- 4. The system of claim 1, wherein the processor is configured to initially perform the calibration of the system by: setting compensation delay provided by the path delay compensator to zero; measuring first phase and second phase of the phase modulated RF signal that passes through the first path and the second path, respectively; and calculating the delay difference between the first path delay and the second path delay based on the measured first phase of the phase modulated RF signal that passes through the first path and the measured second phase of the phase modulated RF signal that passes through the second path.
- 5. The system of claim 4, wherein the processor is configured to calculate the delay difference (t) between the first path delay and the second path delay as follows:
- $\tau = \frac{\sin^{-1}(\frac{\phi_2}{Math. \phi_2. Math.}) \sin^{-1}(\frac{\phi_1}{Math. \phi_1. Math.})}{2\pi f_M}$ wherein f.sub.M is modulation frequency of the phase modulated RF signal generated by the signal source, ϕ .sub.1 is the measured first phase of the phase modulated RF signal that passes through the first path, and ϕ .sub.2 is the measured second phase of the phase modulated RF signal that passes through the second path.
- 6. The system of claim 1, further comprising a zero detector connected to an output of the subtractor, wherein: the subtractor subtracts a phase modulated DUT signal from the first path and a phase modulated second RF signal from the second path following the compensation for the delay difference to output a delay difference signal, the zero detector detects when the delay difference signal is zero, and the processor is configured to initially perform the calibration of the system by receiving the delay difference signal from the zero detector and adjusting the path delay compensator until the delay difference signal indicates no difference between the first path delay and the second path delay.
- 7. The system of claim 1, wherein the path delay compensator compensates for the delay difference between the first path delay and the second path delay by: calculating compensation phase θ according to θ =2 π f.sub.mt, where f.sub.m is offset frequency from a carrier frequency of the RF signal and τ is the delay difference between the first and second path delays; and subtracting the compensation phase θ from the demodulated digitized second RF signal.
- 8. The system of claim 1, further comprising: a modulation source configured to provide a phase modulation signal to the signal source to enable the signal source to provide the phase modulated RF signal for initially performing the calibration of the system.
- 9. The system of claim 8, further comprising: a calibration switch configured to selectively connect the modulation source to the signal source for providing the phase modulation signal to the signal source for initially performing the calibration, and to selectively disconnect the modulation source from the signal source for subsequently measuring the residual noise of the DUT following the calibration.
- 10. A system for canceling signal source noise when measuring residual noise of a device under test (DUT), the system comprising: a signal source configured to generate a radio frequency (RF) signal having signal source noise; a signal splitter configured to divide the RF signal into a first RF signal in a first path and a second RF signal in a second path, wherein the first path introduces a first path delay and the second path introduces a second path delay, and wherein the first path includes the DUT configured to receive the first RF signal as a stimulus signal and to output a DUT signal in response; a first receiver unit comprising a third path configured to receive the DUT signal from the first path and a fourth path configured to receive the second RF signal from the second path, wherein the third path introduces a third path delay and the fourth path introduces a fourth path delay, and wherein the first receiver unit is configured to compensate for a delay difference between a sum of the first and third path delays and a sum of the second and fourth path delays and to eliminate the signal source noise to output a delay compensated first signal including first residual noise of the DUT without the signal source noise; a second receiver unit comprising a fifth path configured to receive the DUT signal from the first path and a sixth path configured to receive the second RF signal from the second path, wherein the fifth path introduces a fifth path

delay and the sixth path introduces a sixth path delay, and wherein the second receiver unit is configured to compensate for a delay difference between a sum of the first and fifth path delays and a sum of the second and sixth path delays and to eliminate the signal source noise to output a delay compensated second signal including second residual noise of the DUT without the signal source noise; and a processor configured to perform cross-correlation of the delay compensated first signal and the delay compensated second signal to provide a cross-correlated signal, and to measure the residual noise of the DUT from the cross-correlated signal.

- 11. The system of claim 10, wherein the first receiver unit further comprises a first local oscillator (LO) configured to generate a first LO signal, wherein the third path comprises a first frequency converter configured to convert a frequency of the DUT signal using the first LO signal to output a first frequency converted DUT signal, and wherein the fourth path comprises a second frequency converter configured to convert a frequency of the second RF signal using the first LO signal to output a first frequency converted RF signal; and wherein the second receiver unit further comprises a second LO configured to generate a second LO signal, wherein the fifth path comprises a third frequency converter configured to convert the frequency of the DUT signal using the second LO signal to output a second frequency converted DUT signal, and wherein the sixth path comprises a fourth frequency converter configured to convert the frequency of the second RF signal using the second LO signal to output a second frequency converted RF signal.
- 12. The system of claim 11, wherein the processor is further configured to reduce first LO noise contribution added to the DUT signal by the first and second LOs, and to reduce second LO noise contribution added to the second RF signal by the first and second LOs, as a side-effect of delay compensation, by averaging the cross-correlation of the delay compensated first and second signals.
- 13. The system of claim 11, wherein in the first receiver unit: the third path further comprises a first analog to digital converter (ADC) configured to digitize the first frequency converted DUT signal to provide a first digitized DUT signal; and a first demodulator configured to demodulate the first digitized DUT signal to provide a first demodulated DUT signal, and the fourth path further comprises a second ADC configured to digitize the first frequency converted RF signal to provide a first digitized RF signal; and a second demodulator configured to demodulate the first digitized RF signal to provide a first demodulated RF signal, and wherein in the second receiver unit: the fifth path further comprises a third ADC configured to digitize the second frequency converted DUT signal to provide a second digitized DUT signal; and a third demodulator configured to demodulate the second digitized DUT signal to provide a second demodulated DUT signal, and wherein the sixth path further comprises a fourth ADC configured to digitize the second frequency converted RF signal to provide a second digitized RF signal; and a fourth demodulator configured to demodulate the second digitized RF signal to provide a second demodulated RF signal. 14. The system of claim 13, wherein the first receiver unit further comprises a first path delay compensator configured to compensate for the delay difference between the sum of the first and third path delays and the sum of the second and fourth path delays, and a first subtractor configured to subtract the first demodulated DUT signal and the first demodulated RF signal following the compensation for the delay difference to output the delay compensated first signal including the first residual noise of the DUT without the signal source noise, and wherein the second receiver unit further comprises a second path delay compensator configured to compensate for a delay difference between the sum of the first and fifth path delays and the sum of the second and sixth delays, and a second subtractor configured to subtract the second demodulated DUT signal and the second demodulated RF signal following the compensation for the delay difference to output the delay compensated second signal including the second residual noise of the DUT without the signal source noise.
- 15. The system of claim 10, further comprising: a modulation source selectively connected to the signal source for providing phase modulation to the signal source for initially performing a

calibration the system including the DUT in the first path, wherein the signal source outputs the RF signal phase modulated by the modulation source at a modulation frequency to provide a phase modulated RF signal during the calibration.

16. A method for canceling signal source noise when measuring residual noise of a device under test (DUT), the method comprising: generating a radio frequency (RF) signal having signal source noise using a signal source; dividing the RF signal into a first RF signal in a first path and a second RF signal in a second path, wherein the first path introduces a first path delay and the second path introduces a second path delay; receiving the first RF signal as a stimulus signal at the DUT in the first path, wherein the DUT outputs a DUT signal in response; receiving the DUT signal at a third path and the second RF signal at a fourth path of a first receiver unit, wherein the third path introduces a third path delay and the fourth path introduces a fourth path delay; converting a frequency of the DUT signal using a first local oscillator (LO) signal generated by a first LO to a first frequency converted DUT signal, and a frequency of the second RF signal using the first LO signal to a first frequency converted RF signal, wherein the first LO introduces first LO noise; compensating for a first delay difference between a sum of the first and third path delays and a sum of the second and fourth path delays and eliminate the signal source noise to output a delay compensated first signal including first residual noise of the DUT without the signal source noise; receiving the DUT signal at a fifth path and the second RF signal at a sixth path of a second receiver unit, wherein the fifth path introduces a fifth path delay and the sixth path introduces a sixth path delay; converting a frequency of the DUT signal using a second LO signal generated by a second LO to a second frequency converted DUT signal, and a frequency of the second RF signal using the second LO signal to a second frequency converted RF signal, wherein the second LO introduces second LO noise; compensating for a second delay difference between a sum of the first and fifth path delays and a sum of the second and sixth path delays and eliminate the signal source noise to output a delay compensated second signal including second residual noise of the DUT without the signal source noise; performing cross-correlation of the delay compensated first signal and the delay compensated second signal to provide a cross-correlated signal, eliminating the first and second LO noise; and outputting the cross-correlated signal as the residual noise of the DUT. 17. The method of claim 16, further comprising: digitizing and demodulating the first frequency converted DUT signal and the first frequency converted second RF signal before compensating for the first delay difference; and digitizing and demodulating the second frequency converted DUT signal and the second frequency converted second RF signal before compensating for the second delay difference.

18. The method of claim 16, further comprising: initially performing a calibration with the DUT included in the first path by controlling the signal source to output a phase modulated RF signal at a modulation frequency, and determining the first and second delay differences using the phase modulated RF signal, during the calibration.